

Notice of References Cited		Application/Control No 10/025,776	Applicant(s)/Patent Under Reexamination KAMBE, TOSHIYUKI	
		Examiner Daniel E Valencia	Art Unit 2874	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,146,518	09-1992	Mak et al	385/41
B	US-5,111,517	05-1992	Riviere, Luc	385/11
C	US-4,390,236	06-1983	Alferness, Rodney C	385/9
D	US-4,142,775	03-1979	Ramaswamy et al	385/41
E	US-4,917,449	04-1990	Granstrand, Per O	385/41
F	US-2002/0025103 A1	02-2002	Thaniyavarn Suwat	385/15
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
U					
V					
W					
X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign

Notice of References Cited		Application/Control No 10/025,776	Applicant(s)/Patent Under Reexamination KAMBE, TOSHIYUKI
		Examiner Daniel E Valencia <i>DV</i>	Art Unit 2874

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,535,653 B1	03-2003	Hung et al	385/2
B	US-6567599 B2	05-2003	Hung	385/132
C	US-2002/0131745 A1	09-2002	Azarbar	385/129
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher Edition or Volume, Pertinent Pages)				
U					
V					
W					
X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign